

| | | | | |
|-----------------------------------|--|---------------------------------------|---------------------------------------------------------------|-------------|
| Notice of References Cited | | Application/Control No. 10/809,202 | Applicant(s)/Patent Under Reexamination DEGOWSKE ET AL. | |
| | | Examiner Ha D. Ho | Art Unit 3681 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|--------------------------------------------------|-----------------|-------------------------|----------------|
| A | US-4,150,385 A | 04-1979 | Ahles, deceased, Alfred | 346/79 |
| B | US-5,853,165 A | 12-1998 | Kuivamaki, Ismo | 254/366 |
| C | US-6,733,411 B1 | 05-2004 | Kaplan et al. | 475/88 |
| D | US-6,796,412 B2 | 09-2004 | Teraoka, Masao | 192/35 |
| E | US-6,832,972 B2 | 12-2004 | Ishikawa, Yasuhiko | 475/223 |
| F | US- | | | |
| G | US- | | | |
| H | US- | | | |
| I | US- | | | |
| J | US- | | | |
| K | US- | | | |
| L | US- | | | |
| M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|--------------------------------------------------|-----------------|---------|-----------------|----------------|
| N | 2-221743 | 09-1990 | JP | Kawamoto et al. | 475/231 |
| O | | | | | |
| P | | | | | |
| Q | | | | | |
| R | | | | | |
| S | | | | | |
| T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|-------------------------------------------------------------------------------------------|--|
| * | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | |
| U | | |
| V | | |
| W | | |
| X | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.